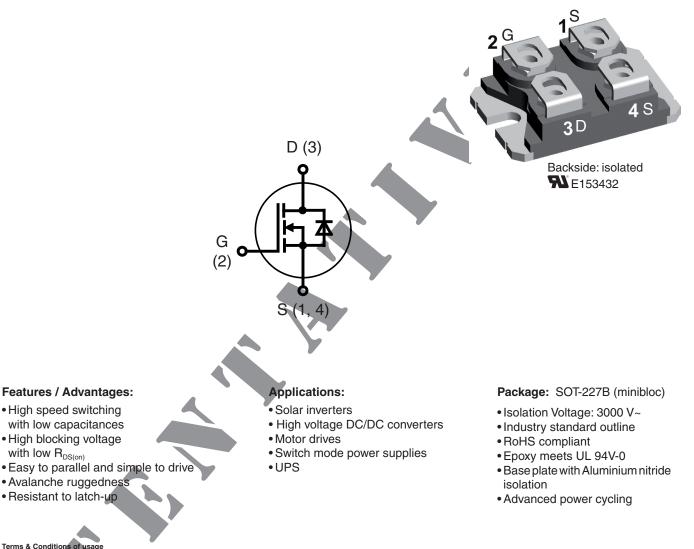
LIXYS

IXFN50N120SiC

SiC Power MOSFET

I _{D25}	=	47	Α
V _{DSS}	=	1200	V
R _{DS(on) max}	=	50	$\mathbf{m}\Omega$

Part number IXFN50N120SiC



Terms & Conditions of usage

The data contained in this product data sheet is exclusively intended for technically trained staff. The user will have to evaluate the suitability of the product for the intended application and the completeness of the product data with respect to his application. The specifications of our components may not be considered as an assurance of component characteristics. The information in the valid application - and assembly notes must be considered as an assurance of component characteristics. The information in the valid application - and assembly notes must be considered. Should you reguire product information in excess of the data given in this product data sheet or which concerns the specific application of your product, please contact the sales office, which is responsible for you. Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact the sales office, which is responsible for you. Should you intend to use the product in aviation, in health or live endangering or life support applications, please notify. For any such application we urgently recommend - to perform joint risk and quality assessments;

- the conclusion of quality agreements;
- to establish joint measures of an ongoing product survey, and that we may make delivery dependent on the realization of any such measures.

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MOSFET				Ratings			
Symbol	Definitions	Conditions		min.	typ.	max.	
V _{DSS}	drain source breakdown voltage					1200	V
V _{GSM} V _{GS}	max transient gate source voltage continous gate source voltage			-10 -5		+25 +20	V V
I _{D25} I _{D80}	drain current		$T_{c} = 25^{\circ}C$ $T_{c} = 80^{\circ}C$			47 35	A A
R _{DSon}	static drain source on resistance	$I_{D} = 40 \text{ A}; V_{GS} = 20 \text{ V}$	$\begin{array}{l} T_{\rm VJ} = & 25^{\circ}{\rm C} \\ T_{\rm VJ} = & 150^{\circ}{\rm C} \end{array}$		40 75	50 105	mΩ mΩ
V _{GS(th)}	gate threshold voltage	$I_{D} = 2 \text{ mA}; V_{DS} = 10 \text{ V}$	$\begin{array}{l} T_{\rm VJ} = & 25^{\circ}{\rm C} \\ T_{\rm VJ} = & 150^{\circ}{\rm C} \end{array}$	1.7 1.2	2.2 1.7		V V
I _{DSS}	drain source leakage current	$ \} V_{DS} = 1200 V; V_{GS} = 0 V $	$\begin{array}{l} T_{vJ}=~25^{\circ}C\\ T_{vJ}=~150^{\circ}C \end{array}$		2 20	200 500	μA μA
I _{GSS}	gate source leakage current	$V_{\rm DS} = 0 \text{ V}; V_{\rm GS} = 20 \text{ V}$	$T_{VJ} = 25^{\circ}C$			0.5	μA
R _G	internal gate resistance					4.8	Ω
C _{iss} C _{oss} C _{rss}	input capacitance output capacitance reverse transfer (Miller) capacitance	$ \ \ \ \ \ \ \ \ \ \ \ \ \ $	T _{vJ} = 25°C	_	1900 160 13		pF pF pF
Q _g Q _{gs} Q _{gd}	total gate charge gate source charge gate drain (Miller) charge	$\left. \right\} V_{DS} = 800 \text{ V}; I_{D} = 40 \text{ A}; V_{GS} = 0/20 \text{ V}$	$T_{VJ} = 25^{\circ}C$		100 22 36		nC nC nC
$\begin{array}{c} t_{d(on)} \\ t_r \\ t_{d(off)} \\ t_f \\ E_{on} \\ E_{off} \\ E_{rec(off)} \end{array}$	turn-on delay time current rise time turn-off delay time current fall time turn-on energy per pulse turn-off energy per pulse reverse recovery losses at turn-off	$\begin{cases} \text{Inductive switching} \\ V_{DS} = 250 \text{ V}; \text{ I}_{D} = 32 \text{ A} \\ V_{GS} = 10 \text{ V}; \text{ R}_{G} = 2 \Omega \text{ (external)} \end{cases}$	T _{vJ} = 25°C				ns ns ns mJ mJ mJ
R _{thJC} R _{thJH}	thermal resistance junction to case thermal resistance junction to heatsink	with heatsink compound; IXYS test	setup		0.65	0.55	K/W K/W

Source-Drain Diode

Source-Drain Diode			Ratings				
Symbol	Definitions	Conditions		min.	typ.	max.	
_{S25} _{S80}	continuous source current		25°C 80°C				A A
V _{SD}	forward voltage drop		= 25°C = 25°C		3.3 3.1		V V
t _{rr} Q _{RM} I _{RM}	reverse recovery time reverse recovery charge (intrinsic diode) max. reverse recovery current	$V_{GS} = -5 \text{ V}; I_F = 40 \text{ A}$ $T_{VJ} = V_R = 800 \text{ V}; -di_F/dt = 700 \text{ A/}\mu\text{s}$	= 25°C		40 330 12.8		ns nC A

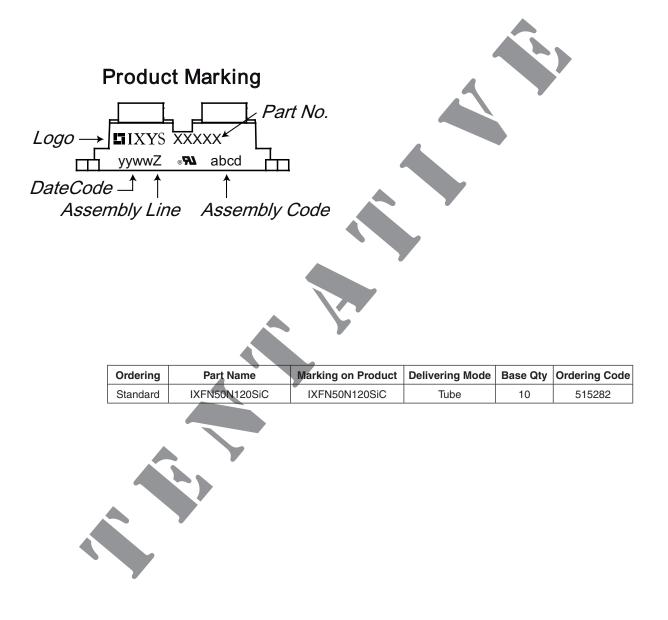


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Package SOT-227B (minibloc)

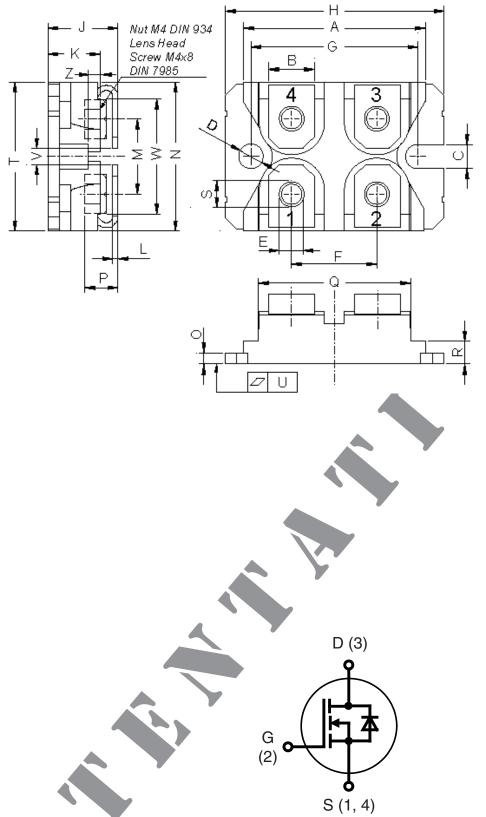
					Ratir	ngs	
Symbol	Definitions	Conditions		min.	typ.	max.	Unit
I _{RMS}	RMS current	per terminal					Α
\mathbf{T}_{stg}	storage temperature			-40		150	°C
T _{op}	operation temperature			-40		150	°C
T _{vJ}	virtual junction temperature			-40		150	°C
Weight					30		g
M _D	mounting torque			1.1		1.5	Nm
Μ _T	terminal torque			1.1		1.5	Nm
d _{Spp/App}	creepage distance on surface	atriking diatanaa through air	terminal to backside	10.5 / 3.2			mm
d _{Spb/Apb}	creepage distance on surface i	sunking distance unough an	terminal to terminal	8.6 / 6.8			mm
VISOL	isolation voltage	I _{ISOL} ≤ 1 mA; 50/60 Hz,	t = 1 sec.	3000			V
			t = 1 minute	2500			V



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Outlines SOT-227B (minibloc)



Dim.	Millimeter		Inches		
Dim.	min	max	min	max	
Α	31.50	31.88	1.240	1.255	
В	7.80	8.20	0.307	0.323	
С	4.09	4.29	0.161	0.169	
D	4.09	4.29	0.161	0.169	
E	4.09	4.29	0.161	0.169	
F	14.91	15.11	0.587	0.595	
G	30.12	30.30	1.186	1.193	
Н	37.80	38.23	1.488	1.505	
Γ	11.68	12.22	0.460	0.481	
К	8.92	9.60	0.351	0.378	
L	0.74	0.84	0.029	0.033	
Μ	12.50	13.10	0.492	0.516	
N	25.15	25.42	0.990	1.001	
0	1.95	2.13	0.077	0.084	
Р	4.95	6.20	0.195	0.244	
Q	26.54	26.90	1.045	1.059	
R	3.94	4.42	0.155	0.167	
S	4.55	4.85	0.179	0.191	
Т	24.59	25.25	0.968	0.994	
U	-0.05	0.10	-0.002	0.004	
V	3.20	5.50	0.126	0.217	
W	19.81	21.08	0.780	0.830	
Ζ	2.50	2.70	0.098	0.106	

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